

Notice of References Cited	Application/Control No. 10/028,402	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Charles E Parsons	Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,275,531	08-2001	Li, Weiping	375/240.12
	B	US-5,767,910	06-1998	Iizuka, Akira	375/240.2
	C	US-6,009,203	12-1999	Liu et al.	382/233
	D	US-6,650,707	11-2003	Youn et al.	375/240.12
	E	US-6,343,098	01-2002	Boyce, Jill MacDonald	375/240.03
	F	US-5,995,150	11-1999	Hsieh et al.	375/240.12
	G	US-5,959,872	09-1999	Son, Jae-Cheol	708/402
	H	US-6,587,590	07-2003	Pan, Feng	382/250
	I	US-6,771,703	08-2004	Oguz et al.	375/240.03
	J	US-6,453,073	09-2002	Johnson, Stephen G.	382/239
	K	US-6,332,194	12-2001	Bloom et al.	713/176
	L	US-6,011,584	01-2000	Allred et al.	348/241
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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